

<b>Notice of References Cited</b>	Application/Control No. 10/670,726		Applicant(s)/Patent Under Reexamination ELIAS ET AL.	
	Examiner BINH K. TIEU		Art Unit 2614	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0213208	10-2004	Baratz et al.	370/352
*	B	US-6,798,872	09-2004	Matsumoto et al.	379/142.01
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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